P-Channel POWERTRENCH® MOSFET

 $-30 \text{ V}, -20 \text{ A}, 14.4 \text{ m}\Omega$

Description

The FDMC6675BZ has been designed to minimize losses in load switch applications. Advancements in both silicon and package technologies have been combined to offer the lowest $R_{DS(on)}$ and ESD protection.

Features

- Max $R_{DS(on)} = 14.4 \text{ m}\Omega$ at $V_{GS} = -10 \text{ V}$, $I_D = -9.5 \text{ A}$
- Max $R_{DS(on)} = 27.0 \text{ m}\Omega$ at $V_{GS} = -4.5 \text{ V}$, $I_D = -6.9 \text{ A}$
- HBM ESD Protection Level of 8 kV Typical (Note 3)
- Extended V_{GSS} Range (-25 V) for Battery Applications
- High Performance Trench Technology for Extremely Low R_{DS(on)}
- High Power and Current Handling Capability
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Load Switch in Notebook and Server
- Notebook Battery Pack Power Management

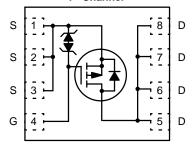


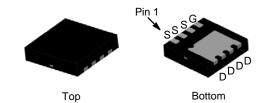
ON Semiconductor®

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V _{DS}	R _{DS(on)} MAX	I _{D MAX}
–30 V	14.4 mΩ @ 10 V	–20 A

P-Channel





WDFN8 3.3x3.3, 0.65P CASE 511DR

MARKING DIAGRAM

\$Y&Z&2&K FDMC 6675BZ

\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &2 = Numeric Date Code

= Lot Code

FDMC6675BZ = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

MOSFET MAXIMUM RATINGS (T_A = 25°C, Unless otherwise specified)

Symbol	Pa	rameter	Ratings	Unit
V _{DS}	Drain to Source Voltage		-30	V
V _{GS}	Gate to Source Voltage		±25	V
I _D	Drain Current – Continuous	T _C = 25°C	-20	Α
	- Continuous	T _A = 25°C (Note 1a)	-9.5	
	- Pulsed		-32	
P _D	Power Dissipation	T _C = 25°C	36	W
	Power Dissipation	T _A = 25°C (Note 1a)	2.3	
T _J , T _{STG}	Operating and Storage Junction Temp	perature Range	-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{ hetaJC}$	Thermal Resistance, Junction to Case	3.4	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Size	Tape Width	Shipping (Qty / Packing) [†]
FDMC6675BZ	FDMC6675BZ	WDFN8 3.3x3.3, 0.65P (MLP) (Pb-Free/Halogen Free)	13″	12 mm	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARA	CTERISTICS					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-30	_	_	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25°C	-	-20	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -24 V, V _{GS} = 0 V V _{DS} = -24 V, V _{GS} = 0 V, T _J = 125°C			-1 -100	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	_	-	±10	μΑ
ON CHARA	CTERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	-1.0	-1.9	-3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25°C	-	-6.0	-	mV/°C
R _{DS(on)}	Static Drain to Source	$V_{GS} = -10 \text{ V}, I_D = -9.5 \text{ A}$	-	10.7	14.4	mΩ
	On Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -6.9 \text{ A}$	-	17.4	27.0	
		V _{GS} = -10 V, I _D = -9.5 A, T _J = 125°C	-	15.2	20.5	1
9FS	Forward Transconductance	$V_{DD} = -5 \text{ V}, I_D = -9.5 \text{ A}$	_	28	_	S

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

DYNAMIC CHARACTERISTICS

C _{iss}	Input Capacitance	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	ı	2154	2865	pF
C _{oss}	Output Capacitance		_	392	525	pF
C _{rss}	Reverse Transfer Capacitance		1	349	525	pF

SWITCHING CHARACTERISTICS

t _{d(on)}	Turn-On Delay Time	$V_{DD} = -15 \text{ V}, I_D = -9.5 \text{ A}, V_{GS} = -10 \text{ V},$	-	11	20	ns
t _r	Rise Time	$R_{GEN} = 6 \Omega$	_	10	20	
t _{d(off)}	Turn-off Delay Time		_	44	71	
t _f	Fall Time		_	26	42	
Q_g	Total Gate Charge	$V_{GS} = 0V \text{ to } -10 \text{ V}, V_{DD} = -15 \text{ V}, I_D = -9.5 \text{ A}$	_	46	65	nC
Q_g	Total Gate Charge	$V_{GS} = 0V \text{ to } -5 \text{ V}, V_{DD} = -15 \text{ V}, I_D = -9.5 \text{ A}$	_	26	37	nC
Q_{gs}	Gate to Source Charge	$V_{DD} = -15 \text{ V}, I_D = -9.5 \text{ A}$	ı	6.4	_	nC
Q_{gd}	Gate to Drain "Miller" Charge	$V_{DD} = -15 \text{ V}, I_D = -9.5 \text{ A}$	-	13	_	nC

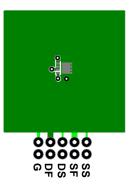
DRAIN-SOURCE DIODE CHARACTERISTICS

V _{SD}	Source to Drain Diode Forward	$V_{GS} = 0 \text{ V}, I_S = -9.5 \text{ A (Note 2)}$	-	-0.89	-1.3	V
	Voltage	$V_{GS} = 0 \text{ V}, I_S = -1.6 \text{ A (Note 2)}$	-	-0.73	-1.2	V
t _{rr}	Reverse Recovery Time	$I_F = -9.5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	_	24	38	ns
Q _{rr}	Reverse Recovery Charge		_	15	27	nC

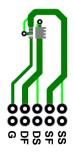
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 \times 1.5 in. board of FR-4 material. $R_{\theta CA}$ is determined by the user's board design.



a) 53°C/W when mounted on a 1 in² pad of 2 oz copper



b) 125°C/W when mounted on a minimum pad

- 2. Pulse Test: Pulse Width $< 300 \mu s$, Duty cycle < 2.0%.
- 3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

TYPICAL CHARACTERISTICS

(T_J = 25 °C unless otherwise noted)

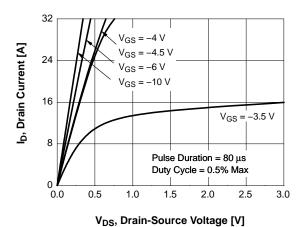
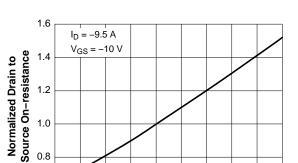


Figure 1. On-Region Characteristics



t_{AV}, Time in Avalanche (ms)

Figure 3. Normalized On Resistance vs Junction Temperature

25 50 75 100 125

0.6

-50

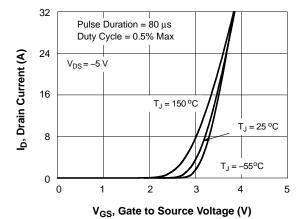
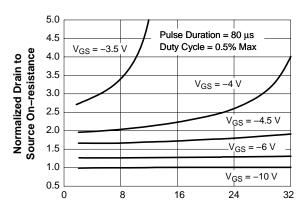


Figure 5. Transfer Characteristics



ID, Drain Current (A)

Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

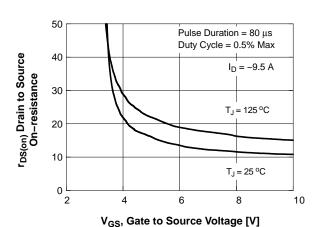
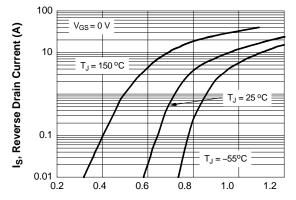


Figure 4. On–Resistance vs Gate to Source Voltage



V_{SD}, Body Diode Forward Voltage (V)

Figure 6. Source to Drain Diode Forward Voltage vs Source Current

TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

(T_J = 25 °C unless otherwise noted)

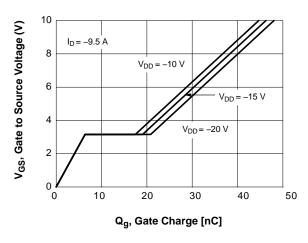


Figure 7. Gate Charge Characteristics

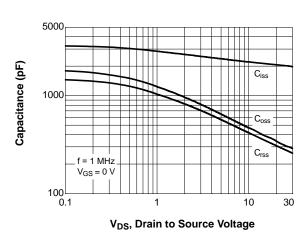


Figure 8. Capacitance vs Drain to Source Voltage

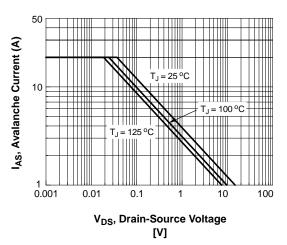


Figure 9. Unclamped Inductive Switching Capability

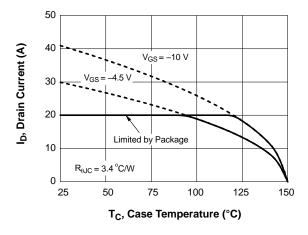


Figure 10. Maximum Continuous Drain Current vs Case Temperature

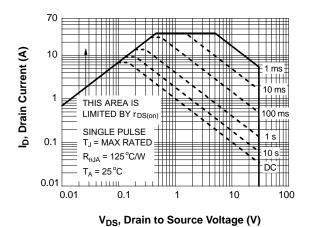


Figure 11. Forward Bias Safe Operating Area

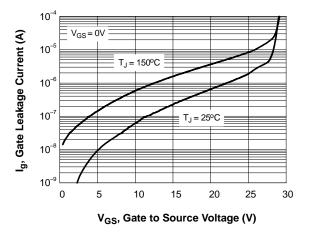


Figure 12. I_{gss} vs V_{gss}

TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

(T_J = 25 °C unless otherwise noted)

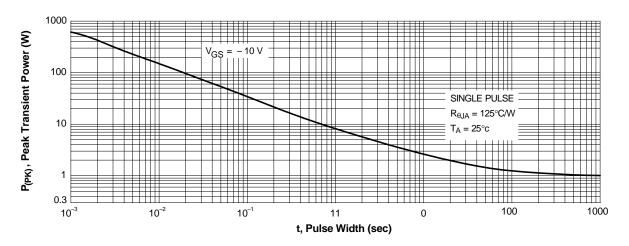


Figure 13. Single Pulse Maximum Power Dissipation

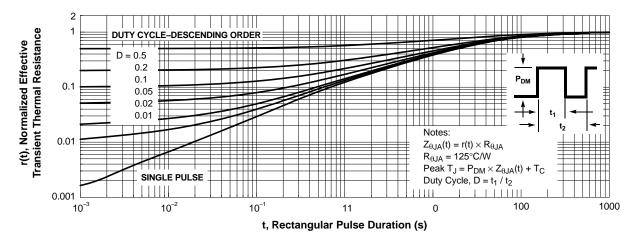


Figure 14. Junction-to-Ambient Transient Thermal Response Curve



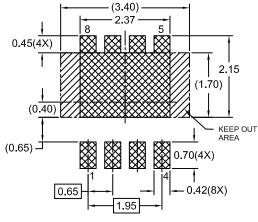


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NOTES:

- A. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- B. SEATING PLANE IS DEFINED BY TERMINAL TIPS ONLY
- C. BODY DIMENSIONS DO NOT INCLUDE MOLD FLASH PROTRUSIONS NOR GATE BURRS. MOLD FLASH PROTRUSION OR GATE BURR DOES NOT EXCEED 0.150MM.

DIM	MIL	MILLIMETERS			
DIM	MIN	NOM	MAX		
Α	0.70	0.75	0.80		
A1	0.00	ı	0.05		
А3	0.15	0.20	0.25		
b	0.27	0.32	0.37		
D	3.20	3.30	3.40		
D1	3.10	3.20	3.30		
D3	2.17	2.27	2.37		
Е	3.20	3.30	3.40		
E1	2.90	3.00	3.10		
E2	1.95	2.05	2.15		
E3	0.15	0.20	0.25		
E4	0.30	0.40	0.50		
E5	0.40 REF				
е	0.65 BSC				
L	0.30	0.40	0.50		
θ	0°	-	12°		

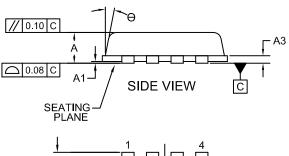


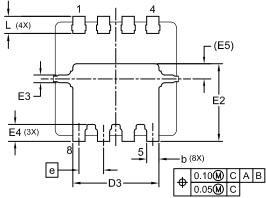
RECOMMENDED LAND PATTERN

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

○ 0.10 C Α 2X В PIN1 □ 0.10 C IDENT

TOP VIEW





BOTTOM VIEW

GENERIC MARKING DIAGRAM*

XXXX AYWW= XXXX = Specific Device Code = Assembly Location = Year = Work Week WW = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

(Note: Microdot may be in either location)

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